

Notice of References Cited	Application/Control No. 09/996,597		Applicant(s)/Patent Under Reexamination ASANO ET AL	
	Examiner Deborah Yee		Art Unit 1742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,475,305	11-2002	Watan et al.	148/320
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	2002-12941	01-2002	Japan	Takashima et al	c22c/38/00
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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